Vishay Siliconix

RoHS

COMPLIANT

Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	500			
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0.40		
Q _g (Max.) (nC)	74			
Q _{gs} (nC)	19			
Q _{gd} (nC)	35			
Configuration	Single			



FEATURES

- Ultra Low Gate Charge
- · Reduced Gate Drive Requirement
- Enhanced 30 V V_{GS} Rating
- Reduced C_{iss}, C_{oss}, C_{rss}
- Isolated Central Mounting Hole
- Dynamic dV/dt Rated
- Repetitive Avalanche Rated
- Lead (Pb)-free Available

DESCRIPTION

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFET technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because of its isolated mounting hole.

ORDERING INFORMATION	
Package	TO-247
Lead (Pb)-free	IRFP450LCPbF
	SiHFP450LC-E3
SnPb	IRFP450LC
	SiHFP450LC

PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-Source Voltage		V_{DS}	500	V	
Gate-Source Voltage	V _{GS}	± 30			
Continuous Drain Current	V_{GS} at 10 V $T_{C} = 25 ^{\circ}\text{C}$	I _D	14	А	
	$T_C = 100 ^{\circ}C$		8.6		
Pulsed Drain Currenta	I _{DM}	56			
Linear Derating Factor			1.5	W/°C	
Single Pulse Avalanche Energy ^b	E _{AS}	760	mJ		
Repetitive Avalanche Currenta	I _{AR}	14	Α		
Repetitive Avalanche Energy ^a	E _{AR}	19	mJ		
Maximum Power Dissipation	T _C = 25 °C	P _D	190	W	
Peak Diode Recovery dV/dt ^c	-T FOR EAVIEW	dV/dt	3.5	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 ^d		
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF WIS SCIEW		1.1	N · m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 25 V, starting T_J = 25 °C, L = 7.0 mH, R_G = 25 Ω , I_{AS} = 14 A (see fig. 12). c. I_{SD} ≤ 14 A, dI/dt ≤ 130 A/ μ s, V_{DD} ≤ V_{DS} , V_{DS} = 150 °C.
- d. 1.6 mm from case.
- * Pb containing terminations are not RoHS compliant, exemptions may apply

IRFP450LC, SiHFP450LC

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THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-	40		
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.65		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	Reference to 25 °C, I _D = 1 mA		0.59	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	V
Gate-Source Leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 50	V _{DS} = 500 V, V _{GS} = 0 V		-	25	μΑ
		V _{DS} = 400 V, V	V _{DS} = 400 V, V _{GS} = 0 V, T _J = 125 °C		-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 8.4 A ^b	-	-	0.40	Ω
Forward Transconductance	9 _{fs}	V _{DS} = 50 V, I _D = 8.4 A ^b		8.7	-	-	S
Dynamic							
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$		-	2200	-	pF
Output Capacitance	C _{oss}			-	320	-	
Reverse Transfer Capacitance	C _{rss}			-	28	-	
Total Gate Charge	Qg	V _{GS} = 10 V		-	-	74	
Gate-Source Charge	Q_{gs}		-	-	19	nC	
Gate-Drain Charge	Q_{gd}		occ ng. c and re	-	-	35	1
Turn-On Delay Time	t _{d(on)}			-	14	-	
Rise Time	t _r	$V_{DD} = 250 \text{ V}, I_D = 14 \text{ A},$ $R_G = 6.2 \Omega, R_D = 17 \Omega, \text{ see fig. } 10^b$		-	49	-	ns
Turn-Off Delay Time	t _{d(off)}			-	30	-	
Fall Time	t _f			-	30	-	
Internal Drain Inductance	L_D	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L _S			-	13	-	- nH
Drain-Source Body Diode Characteristic	s				•	•	
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	14	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	56	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}\text{C}, \ I_S = 14 \text{A}, \ V_{GS} = 0 \text{V}^{\text{b}}$		-	-	1.4	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 14 A, dl/dt = 100 A/μs ^b		-	580	870	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	5.1	7.7	μС
Forward Turn-On Time	t _{on}	Intrinsic turn	-on is dor	ninatad h	v I o and	<u> </u>	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

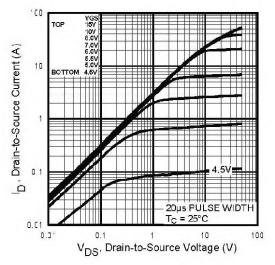


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

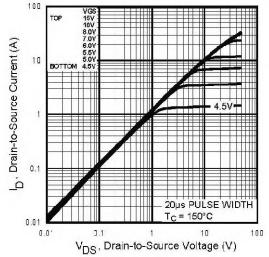


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

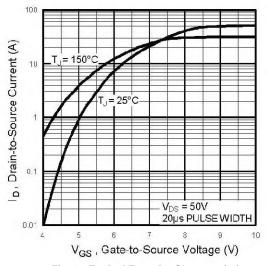


Fig. 3 - Typical Transfer Characteristics

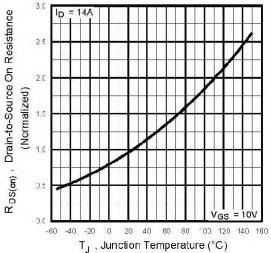


Fig. 4 - Normalized On-Resistance vs. Temperature

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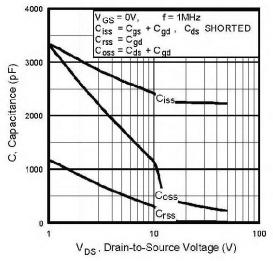


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

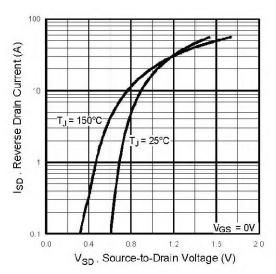


Fig. 7 - Typical Source-Drain Diode Forward Voltage

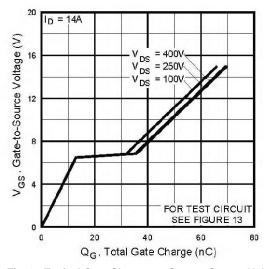


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

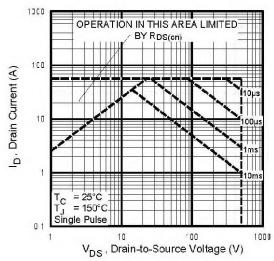


Fig. 8 - Maximum Safe Operating Area

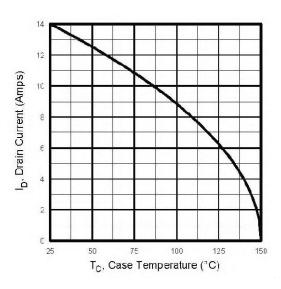


Fig. 9 - Maximum Drain Current vs. Case Temperature

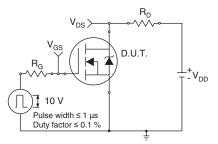


Fig. 10a - Switching Time Test Circuit

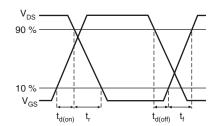


Fig. 10b - Switching Time Waveforms

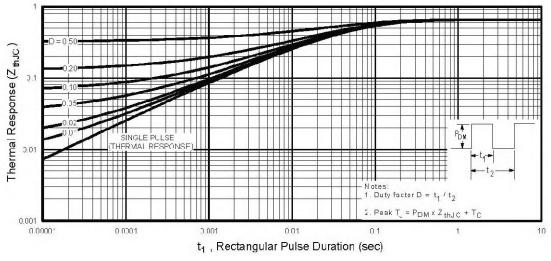


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

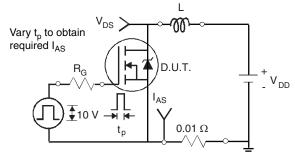


Fig. 12a - Unclamped Inductive Test Circuit

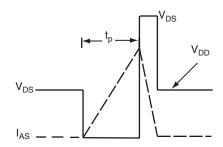


Fig. 12b - Unclamped Inductive Waveforms

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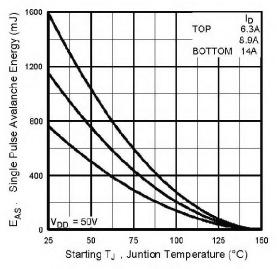


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

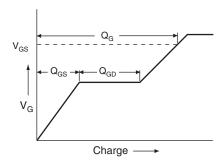


Fig. 13a - Basic Gate Charge Waveform

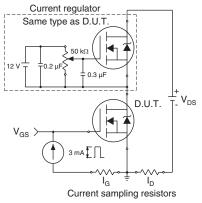
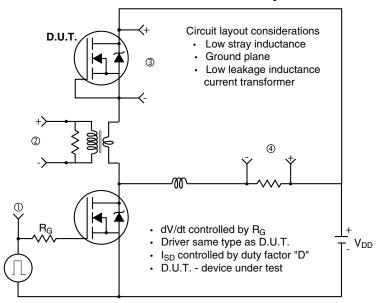
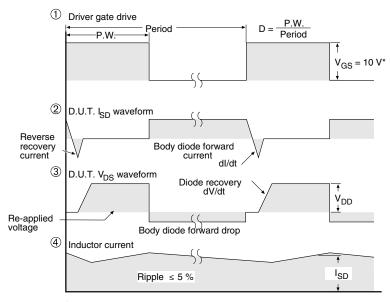


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit





* V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel

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